Spin splitting of upper electron subbands in a SiO$_2$/Si(100)/SiO$_2$ quantum well with in-plane magnetic field

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We observe a lifting of the twofold spin degeneracy of conduction-band electrons in an upper-valley subband with in-plane magnetic field in a SiO$_2$/Si(100)/SiO$_2$ quantum well, which is manifest in a splitting of a feature in the conductivity accompanying the occupation of the upper-valley subband. The splitting increases in proportion to the in-plane magnetic field, allowing the product of the effective g-factor and effective mass $g^\ast m^\ast$ to be obtained. The value remains constant over wide ranges of valley splitting, total electron density, and potential bias. © 2009 American Institute of Physics. [DOI: 10.1063/1.3105987]

Besides the in-plane motion of electrons, the spin degree of freedom plays pivotal roles in the physics of two-dimensional (2D) electron systems. Fundamental phenomena, such as the metal-insulator transition and inelastic scattering, are crucially dependent on electronic spin.1,2 The manipulation of spin is also required for spintronic devices and a number of schemes proposed for quantum information processing.3-5 It is therefore vital to be able to measure, understand, and control spin splitting, which is the energy separation between states of opposite spin.

Here, we examine the Zeeman spin splitting of electrons in a SiO$_2$/Si/SiO$_2$ quantum well formed by fabricating a metal-oxide-semiconductor field-effect transistor (MOSFET) on a thin silicon-on-insulator (SOI) substrate. Since this structure forms the basis of much modern-day silicon nanotechnology and physics research, such basic characterization is important.

In transport measurements on Si, the Zeeman splitting has been analyzed through Shubnikov–de Haas (SdH) oscillations6 and magnetocapacitance measurements7 under magnetic field applied perpendicular to, or tilted against the 2D plane. The perpendicular magnetic field, however, affects the in-plane motion of electrons. Furthermore, Landau quantization and many body interactions are found to give rise to complicated phenomena in SiO$_2$/Si/SiO$_2$ quantum wells, which restricts the use of these techniques to a limited range of electrical bias.8 When only an in-plane magnetic field ($B_p$) is applied so that the in-plane motion of the electrons remains relatively unaffected, the Zeeman splitting can be obtained by resistance saturation at a critical field due to full spin polarization.9 However, this method can only be applied to low electron densities, where full spin polarization can be achieved with accessible magnetic field strength.

In this letter, we show that spin splitting can be detected as alterations to the resistivity at the onset of the occupation of upper subbands. This allows us to extract the product of the g-factor and effective mass at higher electron densities and without the use of a perpendicular component of magnetic field.

In silicon-based 2D systems with (100) orientation, the anisotropy of effective mass and quantum confinement lift the sixfold valley degeneracy present in the bulk to twofold and fourfold degenerate valleys, such that only the twofold degenerate valleys of lowest energy are occupied [Fig. 1(a)]. Recently, the energy splitting of the twofold states (valley splitting) was shown to be observable as features in the conductance without magnetic field and that it can be manipulated through the potential asymmetry in a SiO$_2$/Si/SiO$_2$ quantum well [Figs. 1(c) and 1(d)].10 Here, we examine the effect of $B_p$ on the upper-valley subband. Unlike spatially distinct confinement subbands, valley splitting is found not to depend on the in-plane field,11 which opens up the possibility of isolating the effects of spin.

The sample consisted of a MOSFET fabricated on a SOI substrate as depicted in Fig. 1(b). The buried oxide (BOX)
layer, which acts as a back-gate (BG) oxide, was formed by oxygen ion implantation and high-temperature annealing. The top SiO$_2$ layer acting as a front-gate (FG) oxide was formed by standard thermal oxidation. The nominal thicknesses of the undoped active Si layer, BOX, and top SiO$_2$ were 10, 380, and 74 nm, respectively. Our sample was fabricated into a Hall-bar geometry with n-type contacts degenerately doped with phosphorus. Standard four-terminal ac lock-in measurements were performed using a source-drain voltage of 10 mV at 13 Hz.

The conductivity $\sigma_{xx}$ was measured at a temperature of 1.5 K as a function of FG voltage $V_F$ [upper plot of Fig. 2(a)]. Since the position of the features and the background conductivity vary a great deal with BG voltage $V_B$, we use the double differential $d^2\sigma_{xx}/dV_F^2$ and construct a grayscale plot to highlight the evolution of the features [lower plot of Figs. 2(a) and 2(b)]. As found in previous work on similar devices, feature A represents the threshold of conduction at the mobility edge while features B and C are due to the onset of the occupation of upper subbands. A combination of localization in the upper subband edge and intersubband scattering causes a reduction in the overall mobility when an upper subband begins to occupy. This in turn leads to features in $\sigma_{xx}$.

Feature B in Fig. 2(b) is due to the upper-valley subband. It shows a linear dependence of valley splitting on $\Delta_B$, where $\Delta_B=m_n^*\mathbf{g}^*\mathbf{B}$, which we use to empirically quantify the potential asymmetry of the quantum well, where $m_n^*$ and $\mathbf{g}^*$ are the electron densities contributed from the BG and FG, respectively. We find that consistent with previous work, the valley splitting can be described by $\Delta_B=\alpha\Delta_n$, where $\alpha=\text{const}$. The evolution of feature B is best fitted by a value $\alpha=0.49$ meV/10$^{15}$ m$^{-2}$ (taking the effective mass to be $m^*=0.19$ m$_0$, where m$_0$ is the free electron mass). This corresponds to a valley splitting of around 10 meV at $\Delta_B=2\times10^{16}$ m$^{-2}$ [red dashed line in Fig. 2(b)]. The region between peaks A and B in Figs. 2(a) and 2(b) corresponds to the valley-polarized regime, where only the lower-valley subband is occupied.

Feature C is due to the upper confinement subband as confirmed by its obeying the expected evolution with $V_F$ and $V_B$.

The valley splitting of this confinement subband is small and is not seen in these measurements because its wave function is never pressed close to the Si BOX interface [Fig. 1(d)].

Figures 2(c) and 2(d) show data taken under identical conditions except for a large in-plane magnetic field of 15 T. In these figures, while the magnetic field enhances localization around A and acts only to shift feature A to higher density, it is clearly seen that the feature corresponding to the upper-valley subband (B) splits into two as marked by arrows labeled D and E. We interpret this to be due to spin splitting [Fig. 1(e)].

Since $B_z$ couples not with the in-plane motion of the electrons but with the spin degree of freedom, we assume a model of the density of states (DOS) with only valley and Zeeman splittings to explain these features. From the model, zones of ($V_B, V_F$) in Fig. 2(d) can be classified into three, according to the relative magnitudes of $\Delta_B$ and $\Delta_g=\mathbf{g}^*\mu_B\mathbf{B}$: (I) $\Delta_B<<\Delta_g$, (II) $\Delta_B>>\Delta_g$, and (III) $\Delta_B>\Delta_g$, as schematically depicted in Fig. 3(a), where $\Delta_B$ is the Zeeman splitting, $\mathbf{g}^*$ is the effective g-factor, and $\mu_B$ is the Bohr magneton. A diagram of the DOS for (III) is shown in Fig. 3(b), where the positions of the Fermi energy $E_F$ marked by (i)–(iv) correspond to the regions marked in Fig. 3(a). The DOS of valley and Zeeman split subbands is $D_{2D}^Z$, where $D_{2D}^Z=m^*/\hbar^2$. If $m^*$ and $g^*$ are constant, the lines separating regions (i)–(iv) can be expressed analytically by linear equations as functions of $V_B$ and $V_F$.

We obtain $g^*m^*$ from the separation of the spin split peaks D and E in Fig. 2. $\Delta V_F=E_F^D-E_F^E$, where $E_F^D$ and $E_F^E$ are

![FIG. 2.](image1.png)

![FIG. 3.](image2.png)
the FG voltages at peaks D and E, and correspond to conditions where the Fermi energy is at $E_F^D$ and $E_F^E$ in Fig. 3(b), respectively. The increment of electron density required in order to increase the Fermi energy from $E_F^D$ to $E_F^E$ is

$$\Delta n = n(E_F = E_F^E) - n(E_F = E_F^D) = D_{2D}(\Delta V_{D}^E + \Delta z) - D_{2D}^2(2\Delta V_{D}^D - \Delta z),$$

(1)

where $\Delta V_{D}^D$ and $\Delta V_{D}^E$ are the valley splittings at D and E respectively. Since $\Delta V_F$ can be written as $e\Delta n = C_F \Delta V_F$, $\Delta V_F$ is given by

$$\Delta V_F = \frac{3}{2} \frac{eD_{2D} \Delta z}{C_F(1 + D_{2D} \alpha)} = \frac{3}{2} \frac{e g^* m^* \mu_B B_1}{\hbar^2 C_F(1 + D_{2D} \alpha)},$$

(2)

where $C_F$ is the capacitance between the FG and the 2D electrons. Since parameters $C_F$ and $D_{2D} \alpha$ are determined from SdH oscillations under perpendicular magnetic field$^{10}$ and are constants ($462 \ \mu F/m^2$ and 0.39, respectively), $g^* m^*$ is the only variable.

Note that the separation between the peaks is used instead of the peak positions themselves in order to minimize the ambiguity accompanying the position of the actual subband edge in relation to the feature in the conductivity. The similar appearance of both spin subband edges in Fig. 2(d) suggests that the relative separation between the two peaks in the double differential represents the separation of the two subbands with respect to electron occupation.

Figure 4 shows $\Delta V_F$ extracted from the data at different values of magnetic field at $V_B = 27 \ \text{V}$. The dashed line shows a fit using Eq. (2) giving $g^* m^* = 0.49 n_0$. Applying the same process to data between $V_B = 20 \ \text{V}$ and $V_B = 40 \ \text{V}$ gives similar values as expected from the parallelism of peaks D and E in Fig. 2(d). The independence of $g^* m^*$ from $V_B$ means that this spin splitting is independent of the amplitude of the valley splitting, total electron density, and potential bias.

The values of the $g$-factor and effective mass in bulk Si are found to be about 2 and 0.19$m_0$, respectively. In dilute systems, it has been reported that $g^* m^*$ increases with decreasing electron density, even in our measured electron-density range (from $3.5 \times 10^{15}$ to $1.5 \times 10^{16} \text{m}^{-2}$).$^{9,13,14}$ Although our value does not have an electron-density dependence, it is enhanced compared with the bulk value, as found in previous work.

Finally, we point out that this effect showing spin splitting is not restricted to the upper-valley subband. In Fig. 2(d), the two peaks marked by F and G are consistent with the expected spin splitting of the upper confinement subband edge, demonstrating the generality of this effect. We anticipate that this method can be used to analyze spin-dependent phenomena in a wide range of multisubband systems consisting of other materials as well, by direct transport measurements without complications related to the application of a perpendicular magnetic field.